
Elektromagnetna združljivost (EMC) - 2-8. del: Okolje - Udori napetosti in kratke prekinitve v javnih električnih napajalnih sistemih s statističnimi merilnimi rezultati

Electromagnetic compatibility (EMC) - Part 2-8: Environment - Voltage dips and short interruptions on public electric power supply systems with statistical measurement results

Compatibilité électromagnétique (CEM) - Partie 2-8: Environnement - Creux de tension et coupures brèves sur les réseaux d'électricité publics incluant des résultats de mesures statistiques

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brèves sur les réseaux d'électricité publics
incluant des résultats de mesures statistiques**

Electromagnetic compatibility (EMC) –

Part 2-8:

**Environment – Voltage dips and short
interruptions on public electric power supply
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International Electrotechnical Commission, 3, rue de Varembé, PO Box 131, CH-1211 Geneva 20, Switzerland
Telephone: +41 22 919 02 11 Telefax: +41 22 919 03 00 E-mail: inmail@iec.ch Web: www.iec.ch



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INTERNATIONAL ELECTROTECHNICAL COMMISSION

ELECTROMAGNETIC COMPATIBILITY (EMC) –**Part 2-8: Environment –****Voltage dips and short interruptions on public electric power supply systems with statistical measurement results**

FOREWORD

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IEC 61000-2-8, which is a technical report, has been prepared by subcommittee 77A: Low frequency phenomena, of IEC technical committee 77: Electromagnetic compatibility.

It has the status of a basic EMC publication in accordance with IEC Guide 107.

The text of this technical report is based on the following documents:

Enquiry draft	Report on voting
77A/375/DTR	77A/396/RVC

Full information on the voting for the approval of this technical report can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.